

# AOT1N60

# 600V,1.3A N-Channel MOSFET

# **General Description**

The AOT1N60 have been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular ACDC applications.By providing low  $R_{\rm DS(on)},\,C_{\rm iss}$  and  $C_{\rm rss}$  along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

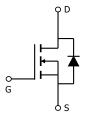
# **Product Summary**

100% UIS Tested 100%  $R_g$  Tested



Top View





Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	600	V	
Gate-Source Voltage		$V_{GS}$	±30	V	
Continuous Drain	T <sub>C</sub> =25°C		1.3		
Current	T <sub>C</sub> =100°C	ID	0.9	A	
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	4		
Avalanche Current <sup>C</sup>		I <sub>AR</sub>	1	A	
Repetitive avalanche energy <sup>C</sup>		E <sub>AR</sub>	15 m		
Single plused avalanche energy <sup>G</sup>		E <sub>AS</sub>	30	mJ	
Peak diode recovery dv/dt		dv/dt	5	V/ns	
	T <sub>C</sub> =25°C	P <sub>D</sub>	41.7	W	
Power Dissipation <sup>B</sup>	Derate above 25°C	- FD	0.3	W/ °C	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	
Maximum lead temperature for soldering		T,	300	°C	

purpose, 1/8" from case for 5 seconds
Thermal Characteristics

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Parameter	Symbol	Typical	Maximum	Units			
Maximum Junction-to-Ambient A,D	$R_{\theta JA}$	55	65	°C/W			
Maximum Case-to-sink <sup>A</sup>	$R_{\theta CS}$	-	0.5	°C/W			
Maximum Junction-to-Case	$R_{\theta JC}$	2	3	°C/W			



#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V, T_J = 25 ^{\circ}C$	600							
		$I_D$ =250 $\mu$ A, $V_{GS}$ =0V, $T_J$ =150°C		700		V				
BV <sub>DSS</sub> /∆TJ	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		0.6		V/°C				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =600V, $V_{GS}$ =0V			1					
		V <sub>DS</sub> =480V, T <sub>J</sub> =125°C			10	μΑ				
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±30V			100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=5V I_{D}=250\mu A$	3	4.1	4.5	V				
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}=10V, I_{D}=0.65A$		7.5	9	Ω				
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 40V, I_{D} = 0.65A$		0.9		S				
$V_{SD}$	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.65	1	V				
I <sub>S</sub>	Maximum Body-Diode Continuous Current				1	Α				
$I_{SM}$	Maximum Body-Diode Pulsed Current				4	Α				
DYNAMIC	PARAMETERS									
$C_{\text{iss}}$	Input Capacitance		100	130	160	pF				
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =25V, f=1MHz	11	14.5	17.5	pF				
C <sub>rss</sub>	Reverse Transfer Capacitance		1.4	1.8	2.2	pF				
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz	2.8	3.5	5.3	Ω				
SWITCHII	NG PARAMETERS									
$Q_g$	Total Gate Charge			6.1	8	nC				
$Q_{gs}$	Gate Source Charge	$V_{GS}=10V, V_{DS}=480V, I_{D}=1A$		1.3	2	nC				
$Q_{gd}$	Gate Drain Charge			3.1	4	nC				
t <sub>D(on)</sub>	Turn-On DelayTime			10	12	ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =300V, $I_{D}$ =1A,		6.7	8	ns				
$t_{\text{D(off)}}$	Turn-Off DelayTime	$R_G=25\Omega$		20	25	ns				
$t_f$	Turn-Off Fall Time			11.5	15	ns				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =1A,dI/dt=100A/μs,V <sub>DS</sub> =100V		114	137	ns				
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=1A,dI/dt=100A/\mu s, V_{DS}=100V$		0.63	0.76	μС				

A. The value of  $R_{\theta,JA}$  is measured with the device in a still air environment with  $T_A = 25^{\circ}$  C.

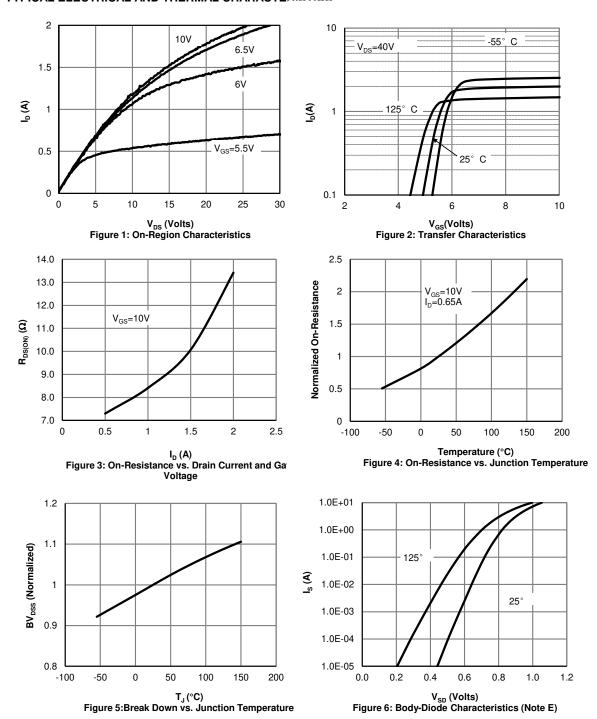
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A. The value of  $R_{0JA}$  is measured with the device in a still air environment with  $T_A$  =25° C. B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used. C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C, Ratings are based on low frequency and duty cycles to keep initial  $T_J$  =25° C. D. The  $R_{oJA}$  is the sum of the thermal impedence from junction to case  $R_{oJC}$  and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating. G. L=60mH,  $I_{AS}$ =1A,  $V_{DD}$ =150V,  $R_{Q}$ =25 $\Omega$ , Starting  $T_{J}$ =25° C

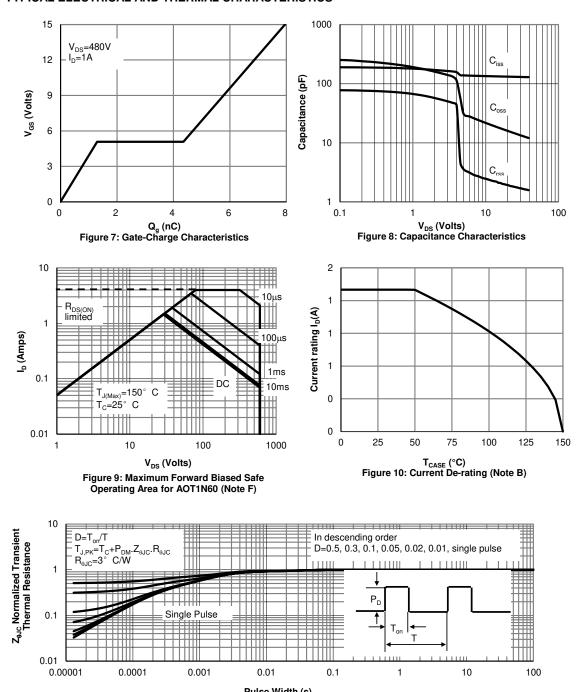


#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





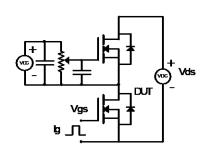
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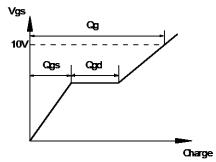


Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance for AOT1N60 (Note F)

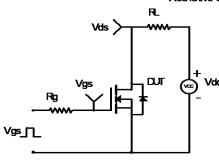


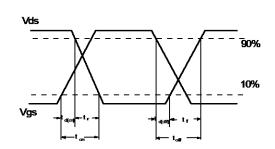
#### Gate Charge Test Circuit & Waveform



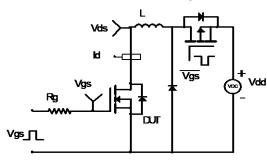


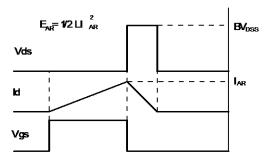
#### Resistive Switching Test Circuit & Waveforms





# Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

